Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10591824	CHAN ET AL.
Examiner	Art Unit
SUCHIRA PANDE	1637

SEARCHED			
Subclass	Date	Examiner	

SEARCH NOTES			
Search Notes	Date	Examiner	
Google search	June 2009	SP	
PALM Inventor name search	July 2009	SP	
East Search	July 2009	SP	
Pubmed search	July 2009	SP	
SPEs Gary Benzion, Peter Paras and Chris Low were consulted re "subject of chinese decent" phrase in claims. Use of this phrase makes this a SAWs case. It was decided that 112 2nd should be done as we do not know how much chinese does one have to be to qualify and how to determine that requisite percentage?	July 2009	SP	
Updated	February 2010	DCT	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examine
	Claim search performed	2/3/2010	DCT

U.S. Patent and Trademark Office Part of Paper No.: 090606-2